

Notice of References Cited		Application/Control No. 09/733,549	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,456,605 B1	09-2002	Laakso et al.	370/330
B	US-6,718,347 B1	04-2004	Wilson, Robert	707/201
C	US-5,526,409 A	06-1996	Conrow et al.	379/91.02
D	US-6,397,043 B1	05-2002	Kang, Mi-jung	455/69
E	US-6,385,180 B1	05-2002	Maru, Tsuguo	370/335
F	US-6,671,266 B1	12-2003	Moon et al.	370/342
G	US-6,549,785 B1	04-2003	Agin, Pascal	455/522
H	US-6,438,119 B1	08-2002	Kim et al.	370/335
I	US-6,633,552 B1	10-2003	Ling et al.	370/318
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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